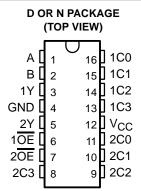
74AC11353 **DUAL 1-OR-4 DATA SELECTOR/MULTIPLEXER**

SCAS044A - JUNE 1988 - REVISED APRIL 1993

- **Inverting Version of 74AC11253**
- Permits Multiplexing from N Lines to 1 Line
- **Performs Parallel-to-Serial Conversion**
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations **Minimize High-Speed Switching Noise**
- **EPIC** ™ (Enhanced-Performance Implanted CMOS) 1-µm Process
- **Package Options Include Plastic** Small-Outline Packages, and Standard Plastic 300-mil DIPs



description

Each of these data selectors/multiplexers contains inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe output-enable (10E or 20E) inputs are provided for each of the two four-line sections.

The 3-state outputs can interface with and drive data lines of bus-organized systems. With all but one of the common outputs disabled (at a high-impedance state), the low impedance of the single enabled output will drive the bus line to a high or low logic level. Each output has its own strobe. The output is disabled when its strobe is high.

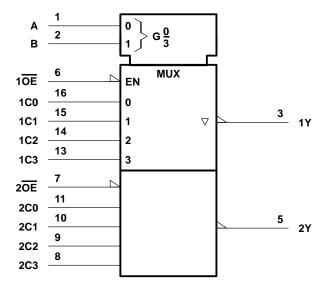
The 74AC11353 is characterized for operation from −40°C to 85°C.

FUNCTION TABLE

SELECT INPUTS		DATA INPUTS				STROBE OE	ОИТРИТ	
В	Α	C0	C 1	C2	C3	OE .	ī	
Х	Х	Х	Χ	Х	Х	Н	Z	
L	L	L	Χ	X	Χ	L	Н	
L	L	Н	Χ	X	X	L	L	
L	Н	X	L	X	X	L	Н	
L	Н	X	Н	X	X	L	L	
Н	L	Х	Χ	L	Χ	L	Н	
Н	L	Х	Χ	Н	Χ	L	L	
Н	Н	Х	Χ	Χ	L	L	Н	
Н	Н	Χ	Χ	X	Н	L	L	

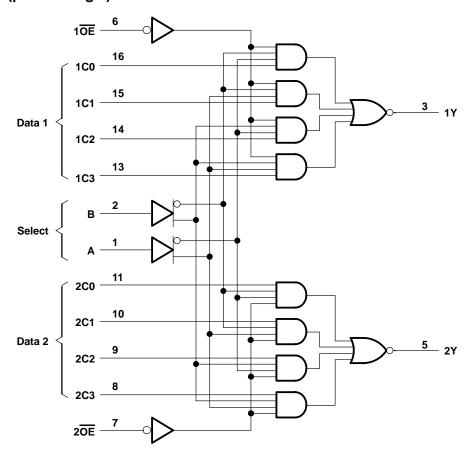
EPIC is a trademark of Texas Instruments Incorporated.

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





SCAS044A - JUNE 1988 - REVISED APRIL 1993

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC} + 0.5 V
Output voltage range, VO (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V _{CC} or GND pins	±100 mA
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		3	5	5.5	V
		V _{CC} = 3 V	2.1			V
V_{IH}	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15			
		$V_{CC} = 5.5 \text{ V}$	3.85			
		V _{CC} = 3 V			0.9	
V_{IL}	Low-level input voltage	$V_{CC} = 4.5 \text{ V}$			1.35	V
		$V_{CC} = 5.5 \text{ V}$			1.65	
٧ _I	Input voltage		0		VCC	V
٧o	Output voltage		0		VCC	V
		V _{CC} = 3 V	_		-4	
lOH	High-level output current	$V_{CC} = 4.5 \text{ V}$			-24	mA
		$V_{CC} = 5.5 \text{ V}$	2.1 3.15 3.85 0.9 1.35 1.65 0 VCC 0 VCC -4			
		V _{CC} = 3 V			12	
lOL	Low-level output current	$V_{CC} = 4.5 \text{ V}$			24	mA
		$V_{CC} = 5.5 \text{ V}$			24	
Δt/Δν	Input transition rise or fall rate	-	0		10	ns/V
TA	Operating free-air temperature		-40		85	°C

SCAS044A - JUNE 1988 - REVISED APRIL 1993

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	TEST CONDITIONS	vcc	MIN	TYP	MAX	IVIIIV	WAX	UNII
		3 V	2.9			2.9		
	$I_{OH} = -50 \mu\text{A}$	4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
VOH	I _{OH} = -4 mA	3 V	2.58			2.48		V
	[4.5 V	3.94			3.8		
	I _{OH} = – 24 mA	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
		3 V			0.1		0.1	
	$I_{OL} = 50 \mu\text{A}$				0.1		0.1	
		5.5 V			0.1		0.1	
VoL	I _{OL} = 12 mA	3 V			0.36		0.44	V
	Jan. 04 m A				0.36		0.44	
	I _{OL} = 24 mA	5.5 V			0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
lį	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μΑ
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
C _i	$V_I = V_{CC}$ or GND	5 V		3.5				pF
СО	$V_O = V_{CC}$ or GND	5 V		8				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNII
^t PLH	A or B	Y	1.5	7	9.6	1.5	10.7	
tPHL		T	1.5	7.2	9.8	1.5	10.9	ns
t _{PLH}	Any C	Y	1.5	6.5	8.6	1.5	9.6	no
tpHL			1.5	6.6	8.7	1.5	9.7	ns
^t PZH	OE	Y	1.5	4.4	6	1.5	6.6	ns
^t PZL	OE	ı	1.5	5.4	7.2	1.5	7.9	115
t _{PHZ}	OE	Y	1.5	4.8	6.2	1.5	6.5	no
tPLZ		1	1.5	4.9	6.3	1.5	6.6	ns

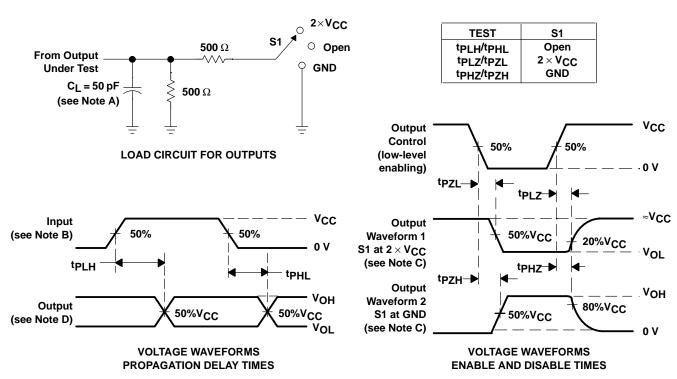
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
FARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	ONIT
^t PLH	A or B	Υ	1.5	4.5	6.6	1.5	7.4	ns
^t PHL		T	1.5	4.6	6.9	1.5	7.6	115
^t PLH	Any C	Υ	1.5	4	5.9	1.5	6.6	ns
^t PHL		1	1.5	4.2	6.1	1.5	6.8	113
^t PZH	OE	Υ	1.5	2.9	4.4	1.5	4.8	ns
^t PZL		ī	1.5	3.4	5.1	1.5	5.6	110
^t PHZ	OE	Υ	1.5	4.4	5.8	1.5	6.1	ns
^t PLZ	OE .	1	1.5	4.1	5.5	1.5	5.8	115

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER			TEST CO	TYP	UNIT	
C _{pd}	Dever dissinction conscitones nor multipleyer	Outputs enabled	C. 50 pF	f = 1 MHz	31	~ F
	Power dissipation capacitance per multiplexer	Outputs disabled	$C_L = 50 \text{ pF},$		12	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_f \leq 3$ ns, $t_f \leq 3$ ns. For testing pulse duration: $t_r = t_f = 1$ to 3 ns. Pulse polarity can be either high-to-low-to-high or low-to-high-to-low.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated